## Searched



Application/Control No.

Applicant(s)/Patent Under Reexamination

10766955

YAMASHITA ET AL.

Examiner

Rossoshek, Helen

Art Unit

2825

Class	SubClass	Date		Examiner
716	1,8,18	02/02/2006	HR	
703	14,17,20,23,27	02/02/2006	HR	
714	739,37	02/02/2006	HR	
710	113	02/02/2006	HR	
UPDATED	UPDATED	08/15/2006	HR	

## Interference Searched



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Class	SubClass	Date		Examiner
716	1,4,8,18	08/15/2006	HR	,
717	140,146	08/15/2006	HR	
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## Search Notes



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Notes	Date	Examiner
EAST - USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	02/02/2006	HR
IEEE	02/02/2006	HR
EAST (US-PGPUB), see search history printout	08/15/2006	HR
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